Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,762	YIN ET AL.	
Examiner	Art Unit	
Tae H. Yoon	1714	

SEARCHED			
Class	Subclass	Date	Examiner
522 523	47	9-16-26	w
523	116		
	112		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Inventor Search	9-16-06	W	
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